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# BGR405

NPN Silicon RF Transistor With Bias Circuitry

Small Signal Discretes

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**BGR405, NPN Silicon RF Transistor With Bias Circuitry**

**Revision History: 2008-06-06, Rev. 1.0**

Prevision History: no previous version

| <b>Page</b> | <b>Subjects (major changes since last revision)</b> |
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**Trademarks**

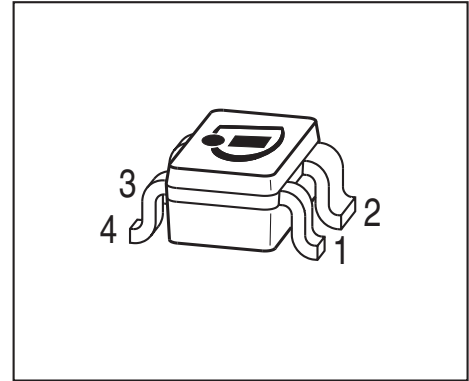
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# 1 NPN Silicon RF Transistor With Bias Circuitry\*

**Features**

- Noise figure  $NF = 1.0$  dB at 0.4 GHz
- Gain  $S_{21} = 7.5$  dB at 0.4 GHz
- On chip bias circuitry, 0.85 mA bias current at  $V_{CC} = 1.2$  V
- SIEGET ® 25 GHz  $f_T$ -Line
- Pb-free (RoHS compliant) package

\* Short term description



**Applications**

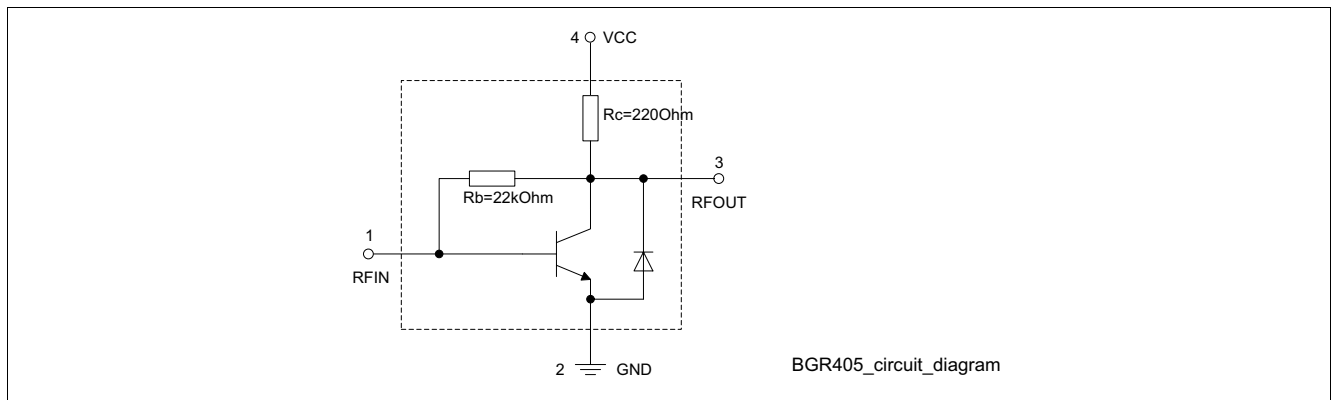
- LNAs

# 2 Description

The BGR405 is a monolithic silicon amplifier with a NPN silicon RF transistor and integrated resistors for biasing.

| Type   | Package | Marking |
|--------|---------|---------|
| BGR405 | SOT343  | AVs     |

*Note: ESD (Electrostatic discharge) sensitive device, observe handling precaution!*



**Figure 1 Circuit diagram**

*Note: Due to design there is an additional diode between emitter and collector, which does not effect normal operation for common emitter configuration.*


**Table 1 Pinning table**

| Pin | Function |
|-----|----------|
| 1   | RFIN     |
| 2   | GND      |
| 3   | RFOUT    |
| 4   | VCC      |

## 2.1 Maximum Ratings

Note: All Voltages refer to GND-node

**Table 2 Maximum ratings**

| Parameter  | Symbol     | Value      | Unit |
|--|------------|------------|------|
| Current at pin VCC   | $I_{CC}$   | 12         | mA   |
| Voltage at pin VCC   | $V_{CC}$   | 5          | V    |
| Current at pin RFIN  | $I_B$      | 0.8        | mA   |
| Voltage at pin RFIN  | $V_B$      | 2          | V    |
| Current at pin RFOUT <sup>1)</sup>                             | $I_{OUT}$  | 12         | mA   |
| Voltage at pin RFOUT   | $V_{OUT}$  | 4.1        | V    |
| Total power dissipation <sup>2)</sup><br>$T_S = 120\text{ °C}$ | $P_{tot}$  | 50         | mW   |
| Operation junction temperature range                           | $T_{jo}$   | -65... 150 | °C   |
| Storage junction temperature range                             | $T_{jstg}$ | -65... 150 | °C   |

1) Applicable if VCC and RFOUT are shorted, otherwise a coupling capacitor at RFOUT is demanded

2)  $T_S$  is measured on the emitter (GND) lead at the soldering point to the pcb

Note: Stresses above the max. values listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions even only for a short moment may affect device reliability. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the integrated circuit. Absolute maximum ratings typically differ heavily from recommended operation conditions.

## 2.2 Thermal Resistance

**Table 3 Thermal Resistance**

| Parameter                                | Symbol     | Value | Unit |
|--|------------|-------|------|
| Junction - soldering point <sup>1)</sup> | $R_{thJS}$ | ≤ 595 | K/W  |

1) For calculation of  $R_{thJA}$  please refer to Application Note Thermal Resistance.

### 3 Electrical Characteristics

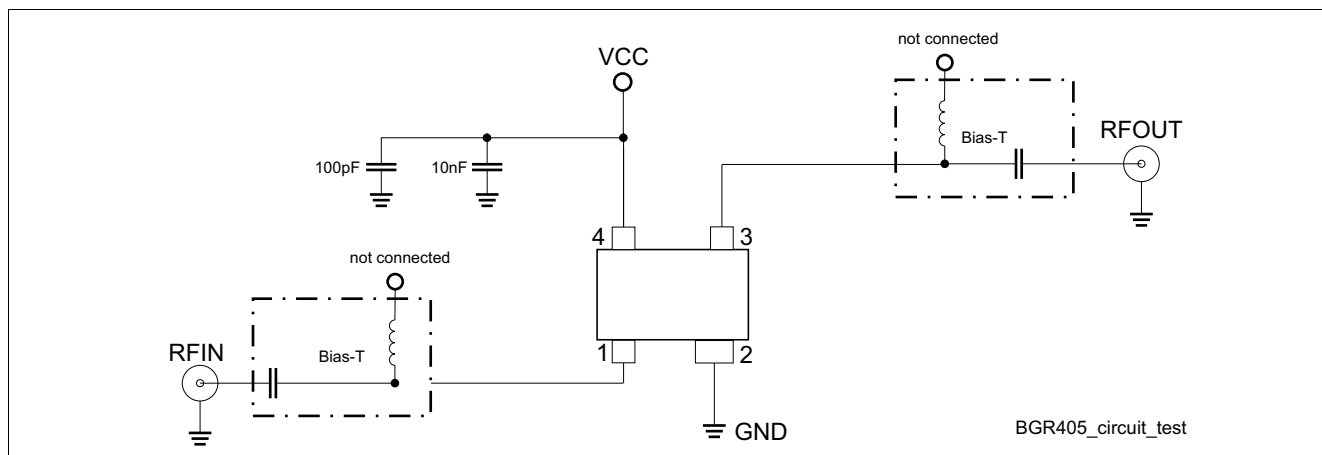
**Table 4 DC characteristics at  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified**

| Parameter      | Symbol   | Values |      |      | Unit | Note / Test Condition   |
|----------------|----------|--------|------|------|------|-------------------------|
|                |          | Min.   | Typ. | Max. |      |                         |
| Device current | $I_{CC}$ | 0.6    | 0.85 | 1.1  | mA   | $V_{CC} = 1.2\text{ V}$ |

**Table 5 AC characteristics (measured in test circuit Figure 2; verified by random sampling)  
 $T_A = 25\text{ }^\circ\text{C}$ ,  $V_{CC} = 1.2\text{ V}$ ,  $Z_0 = 50\text{ }\Omega$ , unless otherwise specified**

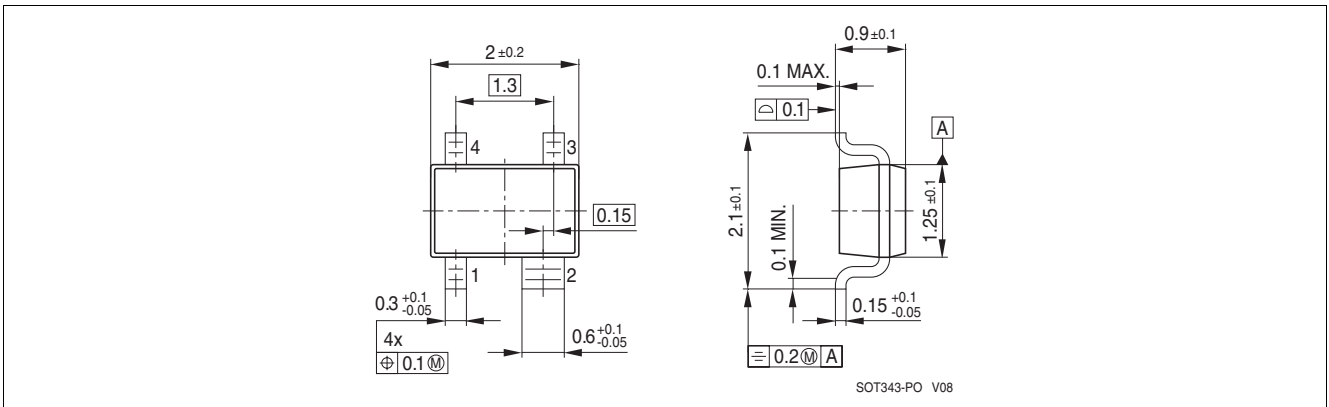
| Parameter   | Symbol      | Values |              |      | Unit | Note / Test Condition  |
|---|-------------|--------|--------------|------|------|--|
|   |             | Min.   | Typ.         | Max. |      |  |
| Insertion power gain                                    | $S_{21}$    |        | 7.5<br>7.0   |      | dB   | $F = 0.4\text{ GHz}$<br>$f = 1.8\text{ GHz}$   |
| Reverse isolation                                       | $S_{12}$    |        | -37<br>-25   |      | dB   | $F = 0.4\text{ GHz}$<br>$f = 1.8\text{ GHz}$   |
| Noise figure, $Z_S = Z_{Sopt}$                          | $NF$        |        | 1.0<br>1.6   |      | dB   | $F = 0.4\text{ GHz}$<br>$f = 1.8\text{ GHz}$   |
| Third order intercept point at the output <sup>1)</sup> | $OIP_3$     |        | -9<br>14.5   |      | dBm  | $F = 0.4\text{ GHz}$ ,<br>$V_{CC} = 1.2\text{ V}$<br>$f = 1.8\text{ GHz}$ ,<br>$V_{CC} = 4\text{ V}$ |
| 1 dB compression point at the output                    | $OP_{-1dB}$ |        | -19<br>-0.5  |      | dBm  | $F = 0.4\text{ GHz}$ ,<br>$V_{CC} = 1.2\text{ V}$<br>$f = 1.8\text{ GHz}$ ,<br>$V_{CC} = 4\text{ V}$ |
| Return loss input                                       | $S_{11}$    |        | -0.4<br>-1.8 |      | dB   | $F = 0.4\text{ GHz}$<br>$f = 1.8\text{ GHz}$   |
| Return loss output                                      | $S_{22}$    |        | -4.0<br>-6.0 |      | dB   | $F = 0.4\text{ GHz}$<br>$f = 1.8\text{ GHz}$   |

1)  $OIP_3$  value depends on termination of all intermodulation frequency components. Termination used for this measurement is  $50\text{ }\Omega$  from 0.1 MHz to 6 GHz.

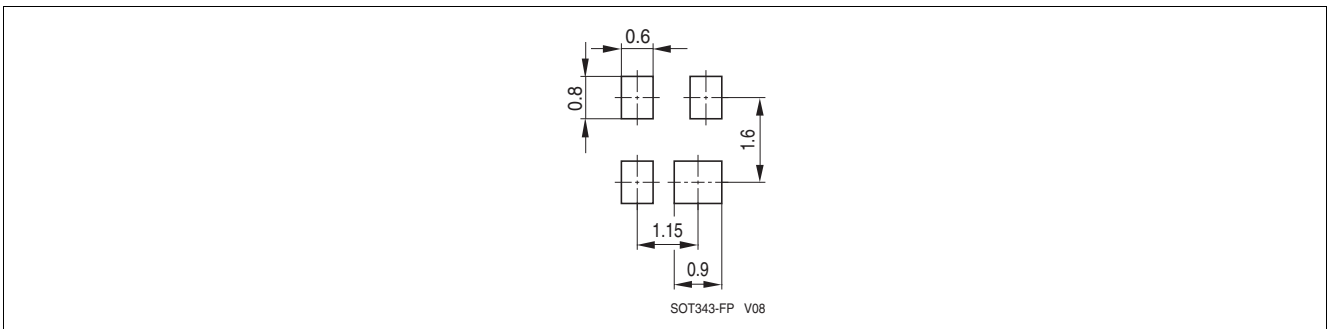


**Figure 2 BGR405 test circuit**

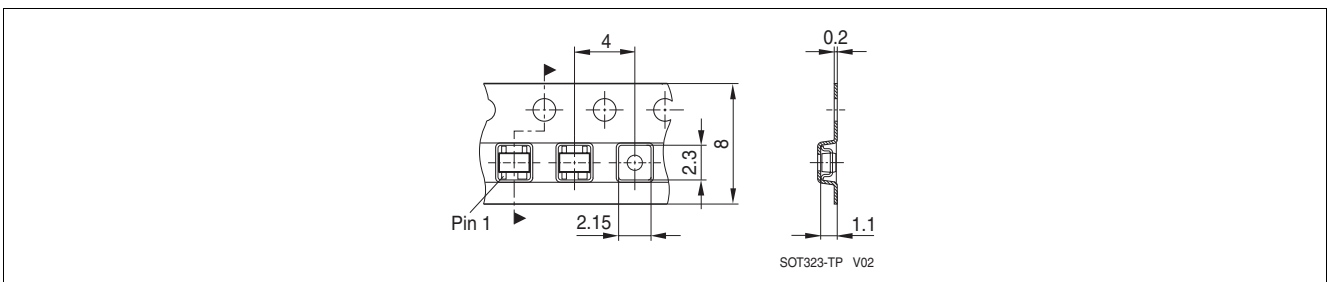
## 4 Package Information



**Figure 3 Package Outline SOT343**



**Figure 4 Footprint of SOT343**



**Figure 5 Tape of SOT343**